## **LCR Meters**

### High-speed, Large-capacitance MLCC Inspection with Constant Voltage



Supports C measurements with voltage dependency characteristics through the

Model 3504-60 can detect contact failure on all 4 terminals for increased reliability BIN function on the 3504-60/-50 is ideal for sorting machines

In all models, contact error is constantly monitored during measurement,

This product is not supplied with measurement probes or test fixtures. Please select and purchase the measurement probe or test fixture options appropriate for your application separately. For an RS-232 connection: A crossover cable for interconnection can be used. You can use the RS-232C CABLE 9637

CONTACT TIPS

To replace the tip on

the L2001, regular size.

bundled with the L2001

IM9901

acing

Model 3504-40 offers high speed and affordability, perfect for integrating into

(Built-in RS-232C interface) (Built-in GP-IB, RS-232C)

(Built-in GP-IB, RS-232C)

CONTACT

size

TIPS IM9902

To replace the tip

on the L2001, small

High speed measurement of 2ms

contributing to increased vield Model No. (Order Code) 3504-40

> 3504-50 3504-60

taping machines

without hardware flow control.

PINCHER PROBE L2001

Cable length 73 cm (2.40 ft), DC

to 8 MHz, impedance characteris-

tics of 50 Ω, 4-terminal pair con

on, tip electrode

0.3 (0.01 in) to 6 mm (0.24 in)

use of constant voltage testing (CV)



Measurement range C: 0.9400 pF to 20.0000 mF, D: 0.00001 to 1.99999 (Typ.) C: ±0.09 % rdg ±10 dgt, D: ±0.0016 Basic accuracy Measurement frequency 120 Hz, 1 kHz 100 mV (3504-60 only), 500 mV, 1 V rms Measurement signal level

Basic specifications (Accuracy guaranteed for 6 months) Measurement parameters C (capacitance), D (loss coefficient tan b)

CV 100 mV Measurement range: up to 170  $\mu F$  range (Source frequency 1 kHz), up to 1.45 mF range (Source frequency 120 Hz) CV 500 mV Measurement range : up to 170  $\mu F$  range (Source frequency 1 kHz), up to 1.45 mF range (Source frequency 120 Hz) CV 1V Measurement range : up to 70 µF range (Source frequency 1 kHz), up to 700 µF range (Source frequency 120 Hz) Output impedance  $5\Omega$  (In open terminal voltage mode outside of the CV measurement range) LED (six digits, full scale count depends on measurement range) Display Measurement time 2 ms (Typ. value. Depends on measurement configuration settings) 4-terminal contact check function (3504-60 only) BIN (measurement values can be classified by rank) (3504-50, 3504-60), Trigger-synchronous output, Setting configurations can be stored, Comparator, Functions Averaging, Low-C reject (bad contact detection), Chatter detection, EXT. I/O, RS-232C GP-IB (3504-50, 3504-60) Selectable from 100, 120, 220 or 240 V AC ±10 %, 50/60 Hz, 110 VA max. Power supply Dimensions and mass 260 mm (10.24 in)W × 100 mm (3.94 in)H × 220 mm (8.66 in)D, 3.8 kg(134.0 oz)

Included accessories Power cord ×1, Instruction manual ×1, Spare fuse ×1

TEST FIXTURE 9262

9261

ft) length, impedance characteristics of 75  $\Omega$ 

Direct connection type, DC to 8 MHz, measurable conductor diameter: Ø0.3

(0.01 in) to 2 mm (0.08 in)





ft) length, impedance characteristics of 75  $\Omega$ 

TEST FIXTURE DC to 8 MHz, 1 m (3.28

### High-precision Portable Resistance Meter Measures from $\mu\Omega$ to $M\Omega$

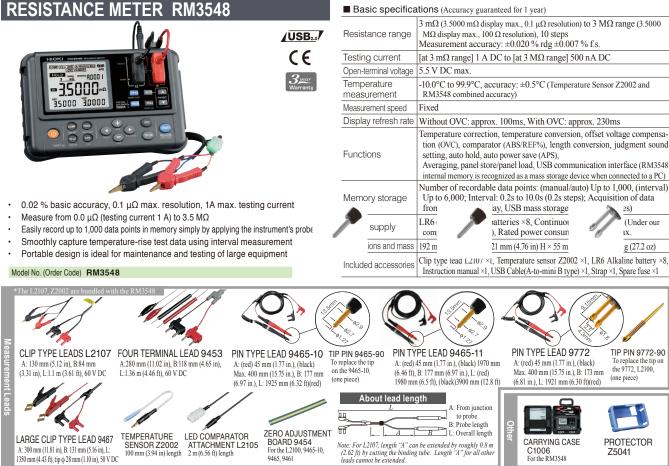
SMD TEST FIXTURE 9699

max. 1.5 mm (0.06 in) high

Direct connection type, For measuring

SMDs with electrodes on the bottom; DC

to 120 MHz, test sample dimensions: 1.0 mm (0.04 in) to 4.0 mm (0.16 in) wide,



SMD TEST FIXTURE 9677

Direct connection type, For measuring SMDs with electrodes

on the side; DC to 120 MHz, tes

sample dimensions: 3.5 mm ±0.5 mm (0.14 in ±0.02 in)

SMD TEST

FIXTURE 9263

Direct connection type

nsions:1 mm (0.04 in)

DC to 8 MHz, test s

to 10 mm (0.39 in)

## Impedance Analyzers/LCR Meters

# For LCR Meters and Impedance Analyzers Probes & Test Fixtures and Applicable SMD size

Please use the probes specified below. For probe characteristic impedance of 50 Ω, a 50 Ω coaxial cable is used. For probe characteristic impedance of 75 Ω, a 75 Ω coaxial cable is used

Unit: mm (inch)

#### Probes and Test Fixtures for Lead Components

20 (0.79)

20F

Max o5.0 (0.2)



FOUR-TERMINAL PROBE L2000 Cable length 1 m (3.28 ft), DC to 8 MHz, impedance characteristics of 50 Ω, 4-terminal pair configuration, measurable conductor diameter: 00.3 (0.01 in) to 5 mm (0.20 in)





Ó

85 (3.3

188 (7.4)

1000 (39

TEST FIXTURE 9261-10 Cable length 1 m (3.28 ft), DC to 8 MHz, impedance characteristics of 50 Q. 4-terminal pair configuration, measurable conductor diameter: 0.3 (0.01 in) to 1.5 mm (0.06 in)

#### Test Fixtures for SMDs

✓ : Measurable▲ : Not recommended Applicable SMD size

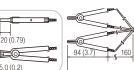
**TEST FIXTURE 9261** Impedance characteristics of 75  $\Omega$ , 4-terminal configuration, Other specifications are the same as for the 9261-10



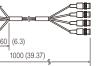
4-TERMINAL PROBE 9140-10 Cable length 1 m (3.28 ft). DC to 200 kHz. impedance characteristics of 50 Q, 4-terminal pair configuration, measurable conductor diameter: 00.3 (0.01 in) to 5 mm (0.20 in)



**TEST FIXTURE 9262** Direct connection type, DC to 8 MHz, measurable conductor diameter: 00.3 (0.01 in) to 2 mm (0.08 in)



4-TERMINAL PROBE 9140 Cable length 1 m (3.28 ft). DC to 100 kHz, impedance characteristics of 75 Ω, 4-terminal configuration, measurable conductor diameter 00 3 (0 01 in) to 5 mm (0 20 in)



Unit: mm (inch)



SMD type L2001 L2001 IM9202 IM9201 IM9110 IM9100 9699 9677 9263 Length: L Width: W JIS CODE EIA CODE (metric) (inch) with tip IM9901 with tip IM9902 008004 0.25 mm (0.01 in) 0.125 mm (0.005 in) 0201 1 0402 01005 0.40 mm (0.02 in) 0.20 mm (0.01 in) 0603 0201 0.60 mm (0.02 in) 0.30 mm (0.01 in) J 1 1 1005 0402 1.00 mm (0.04 in) 0.50 mm (0.02 in) 1 1608 0603 1.60 mm (0.06 in) 0.80 mm (0.03 in) 1 1 1 1 1 1 2012 0805 2.00 mm (0.08 in) 1.25 mm (0.05 in) 1 1 1 3 20 mm (0 13 in) 1.60 mm (0.06 in) 3216 1206 1 1 1 1 ۸ 3225 1210 3.20 mm (0.13 in) 2.50 mm (0.10 in) 1 1 4 50 mm (0 18 in) 4532 1812 3 20 mm (0 13 in) 1 1 1 5750 2220 5.70 mm (0.22 in) 5.00 mm (0.20 in) 1







SMD TEST FIXTURE IM9100

SMDs with electrodes on the

metric(inch): 0402(01005),

0603(0201), 1005(0402)

Direct connection type,

bottom, DC to 8 MHz.





SMD TEST FIXTURE IM9201 Use in combination with the IM9200

01005



precision four-terminal measurement to reliably apply four probes to the SMD's small electrodes.



5.8 (0.23

Unit: mm (inch)



PINCHER PROBE L2001 Cable length 73 cm (2.40 ft), DC to 8 MHz, impedance characteristics of 50 Ω, 4-terminal pair configuration, tip electrode spacing: 0.3 (0.01 in) to 6 mm (0.24 in)

ADAPTER(3.5mm/7mm)

3.5 mm (0.14 in) male to 7

mm (0.28 in) conversion

IM9906



CALIBRATION KIT

Open/Short/Load set

IM9905

Direct connection type, For measuring SMDs with electrodes on the bottom; DC to 120 MHz, test sample dimensions: 1.0 mm (0.04 in) to 4.0 mm (0.16 in) wide, max. 1.5 mm (0.06 in) high



Unit: mm (inch)



CONTACT TIPS IM9902 L2001, small size

Probe contact Advanced contact technolo Auvanced contact technology delivers highly reproducible measurement results.

4easurement probe dian 0.155 mm

SMD TEST FIXTURE IM9110 Direct connection two-terminal measurement type for measuring SMDs. DC to 1 MHz. measurable sample sizes: 008004 (inch)



Enlarged view



measuring SMDs with electrodes on the side; DC to 120 MHz, test sample dimensions: 3.5 mm ±0.5 mm (0.14 in ±0.02 in)

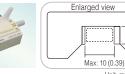












for various SMD sizes

0201

(inch)

0402

SMD TEST FIXTURE 9263 Direct connection type, DC to 8 MHz, Test sample dimensions: 1 mm (0.04 in) to 10 mm (0.39 in)



To replace the tip on the

## **Resistance Meters**

#### Featuring Super-high Accuracy and Multi-channel Capabilities (20 channels with 4-terminal measurement) **RESISTANCE METER RM3545** ■ Basic specifications (Accuracy guaranteed for 1 year)

Resistance range

Testing current

Temperature

measurement

Measurement speed

age

Open-terminal volt-





- /RS-232C/ USB<sub>2.0</sub> CE 3 year
- 0.006% basic accuracy, 0.01  $\mu\Omega$  max. resolution, 1A max. testing current
- Measure from 0.00  $\mu\Omega$  (testing current 1 A) to 1200  $M\Omega$ Multiplexer Unit Z3003 (option) provides 20-channels of 4-terminal measurements for a complete assessment of multi-point signals (RM3545-02 only)
- Low-power resistance measurement with an open voltage not exceeding 20 mV High-speed, comprehensive productivity support delivers decisions in as little as

RM3545-02 (Support for the multiplexer unit)

2.0 ms from start to finish Model No. (Order Code) RM3545 RM3545-01 (Built-in GP-IB interface)



) Hz/60 Hz, Rated power consumption: 40 VA max.  $(80 \text{ mm} (3.15 \text{ in}) \text{ H} \times 306.5 \text{ mm} (12.07 \text{ in}) \text{ D})$ 1] 2.5 kg (88.2 oz), [RM3545-02] 3.2 kg (112.9 oz)

 $10 \text{ m}\Omega (12.00000 \text{ m}\Omega \text{ display max.}, 10 \text{ n}\Omega \text{ resolution}) \text{ to } 1000 \text{ M}\Omega \text{ range}$ 

[LP ON] 1000 m $\Omega$  (1200.00 m $\Omega$  display max., 10  $\mu\Omega$  resolution) to 1000  $\Omega$ 

20 V DC max. (10 kΩ range or more), 5.5 V DC max. (1000 Ω range or less)

FAST (2.0ms) / MED (50Hz: 22ms, 60Hz: 19ms) / SLOW1 (102ms) / SLOW2 (202ms) \* Measurement speed is different at each range, 2.0 ms is the fastest value

Temperature correction, temperature conversion, offset voltage compensation

-10.0°C to 99.9 °C, accuracy: ±0.5 °C (Temperature Sensor Z2001 and RM3545 combined accuracy), -99.9°C to 999.9°C (analog input)

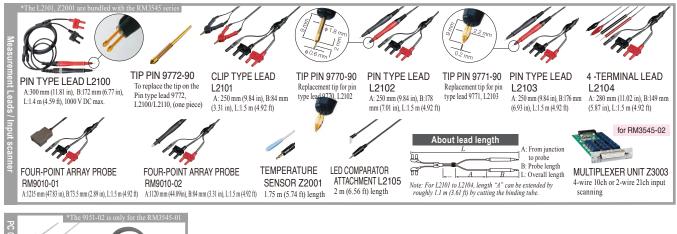
(1200.0 MΩ display max., 100 kΩ resolution), 12 steps

1 A DC to 100 nA DC [LP ON] 1 mA to 5 µA DC

[LP ON] 20 mV DC max.

range (1200.00  $\Omega$  display max., 10 m $\Omega$  resolution), 4 steps Measurement accuracy: ±0.006 % rdg ±0.001 % f.s.

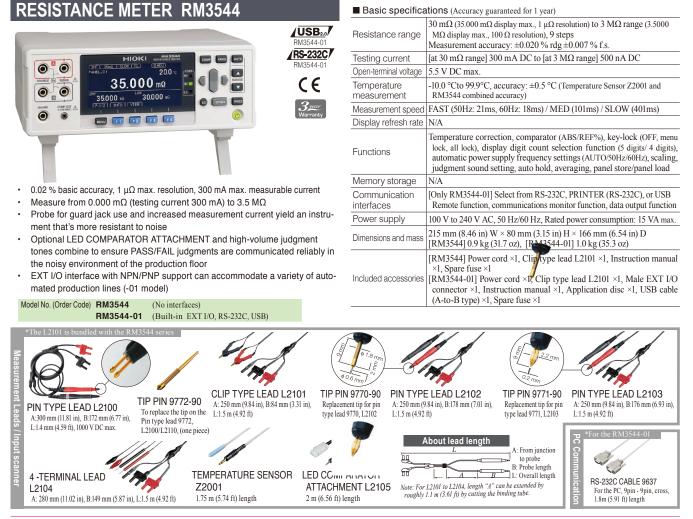
Power coru ×1, C11 iype 1ead L2101 ×1, temperature sensor Z2001 ×1, Male EXT I/O connector Included accessories ×1, Instruction manual ×1, Application disc ×1, USB cable (A-to-B type) ×1, Spare fuse ×1



RS-232C CABLE 9637 GP-IB CONNECTOR CABLE For the PC, 9pin - 9pin, cross 1.8m (5.91 ft) length 9151-02 2m (6.56 ft) length

## **Resistance Meters**

### Long-Selling Model for Low Resistance Measurement



### Resistance Meter for Ultra-low and Low Shunt Resistance **RESISTANCE HITESTER RM3543**



- Advanced enough to measure 0.1 m $\Omega$  shunts with room to spare at  $\pm 0.16\%$ . accuracy & 0.01μΩ resolution performance
- Superb repeatable measurement accuracy
- Advanced contact-check, comparator, and data export functions
- Intuitive user interface and strong noise immunity are ideal for automated systems

Model No. (Order Code) RM3543 RM3543-01 (Built-in GP-IB interface) Test fixtures are not supplied with the unit. Select an optional test fixture when ordering.



Measurement method	Four-terminal, constant-current DC
Resistance range	10 m $\Omega$ (max. 12.00000 m $\Omega,$ 0.01 $\mu\Omega$ resolution) to 1000 $\Omega$ range (max. 1200.000 $\Omega,$ 1 m $\Omega$ resolution), 6 steps
Display	Monochrome graphic LCD 240 × 64 dot, white LED backlight
Measurement accuracy	[at 10 mΩ range, with SLOW mode, average 16 times settings] $\pm 0.060$ % rdg $\pm 0.001$ % f.s.
Testing current	[at 10 m $\Omega$ range] 1 A DC to [at 1000 $\Omega$ range] 1 m A DC
Open-terminal voltage	20 V DC max. Note: Voltage when not measuring is 20 mV or less, with current mode set at PULSE and Contact Improver Setting set at OFF/PULSE (measured with a voltmeter having $10 M\Omega$ )
Sampling rate	FAST, MEDIUM, SLOW, 3 settings
Integration time	$ \begin{array}{l} \mbox{[at 10 m\Omega range, default value] FAST 2.0 ms, MED 5.0 ms, SLOW 1 PLC, \\ \mbox{Setting range: } 0.1 ms to 100.0 ms, or 1 to 5 PLC at 50 Hz, 1 to 6 PLC at 60 \\ \mbox{Hz} \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \$
Other functions	Comparator (compare setting value with measurement value), Delay, OVC (offset voltage compensation), Average, Measurement fault detection, Probe short-circuit detection, Improve contact, Current mode setting (A pulse application function that applies current only during measurement), Auto-memory, Statistical calculations, Settings monitor (when using two instruments, a difference in settings causes warning notification), Retry, Triggen function. etc
Interfaces	External I/O, RS-232C, Printer (RS-232C), GP-IB (Model RM3543-01)
External I/O	Trigger, Hold input, Comparator output, Settings monitor terminal, Service power output +5V, +12V, etc.
Power supply	100 V to 240 V AC, 50 Hz/60 Hz, 40 VA max.
Dimensions and mass	260 mm (10.24 in) W $\times$ 88 mm (3.46 in) H $\times$ 300 mm (11.81 in) D, 3.0 kg (105.8 oz)
Included accessories	Power cord ×1, EXT I/O male connector ×1, Instruction manual ×1, Operation guide ×1



sions:1 mm (0.04 in) to 10 mm

(0.39 in)



## **Resistance Meters**

## High-Speed Resistance Meter Ideal for Automated Lines; Compatible with Super-Small Electronic Components



- Applied voltage limit function lets you switch the detection voltage to 5 V or less
  Contact improvement function suppresses rush current to aid in probing of supersmall components
- Extensive selection of measurement ranges ensures the right detection voltage and delivers stable measurement
- Scaling function corrects for mounting state and test stage differences

#### Model No. (Order Code) RM3542-50

#### **RM3542-51** (Built-in GP-IB interface)

Test fixtures are not supplied with the unit. Please select an optional test fixture when ordering.

Basic specifications (Accuracy guaranteed for 1 year)	
Resistance range	[at Low Power OFF] 100 m $\Omega$ range (max. 120.0000 m $\Omega$ , 0.1 $\mu\Omega$ resolution) to 100 M $\Omega$ range (max. 120.0000 M $\Omega$ , 100 $\Omega$ resolution), 16 steps [at Low Power ON] 1000 m $\Omega$ range (max. 1200.000 m $\Omega$ , 1 $\mu\Omega$ resolution) to 1000 $\Omega$ range (max. 1200.000 $\Omega$ , 1 m $\Omega$ resolution), 6 steps
Display	Monochrome graphic LCD 240 × 64 dot, white LED backlight
Measurement accuracy	[with SLOW mode, at 100 m $\Omega$ range] ±0.015 % rdg ±0.002 % f.s. [with SLOW mode, at 1000 $\Omega$ range] ±0.006 % rdg ±0.001 % f.s. (best case)
Testing current	[at 100 mΩ range] 100 mA DC to [at 100 MΩ range] 100 nA DC
Open-terminal voltage	20 V DC max. (with applied voltage limit function enabled: 10 V DC max.)
Sampling rate	FAST, MEDIUM, SLOW, 3 settings
Measurement times	[at 100 $\Omega$ / 300 $\Omega$ / 1000 $\Omega$ ranges, with Low Power OFF] FAST: 0.9 ms, MED: 3.6 ms, SLOW: 17 ms (minimum time)
Integration time	0.1 ms to 100.0 ms, or 1 to 5 PLC at 50 Hz, 1 to 6 PLC at 60 Hz Note: PLC = one power line cycle (mains wave-form period)
Other functions	Comparator (compare setting value with measurement value), Delay (set to allow for mechani- cal delay of trigger input and probing, or set to allow for measurement object response), Applied Voltage Limit Function, Scaling Function, OVC (offset voltage compensation), Measurement fault detection, Probe short-circuit detection, Improve contact, Auto- memory, Statistical acludations, Settings monitor (when using two instruments, a diffe- ence in settings causes warning notification), Retry, Trigger function, Sample printing, etc
Interfaces	RS-232C, Printer (RS-232C), GP-IB (Model RM3542-51)
External I/O	Trigger, Hold input, Comparator output, Settings monitor terminal
Power supply	100 V to 240 V AC, 50 Hz/60 Hz, 30 VA max.
Dimensions and mass	260 mm (10.24 in) W × 88 mm (3.46 in) H × 300 mm (11.81 in) D, 2.9 kg (102.3 oz)
Included accessories	Power cord ×1, EXT. I/O male connector ×1, Instruction manual ×1, Operation guide ×



### Measure in as Fast as 0.9 ms, Optimized for Automated Systems



- High speed and accuracy maximize productivity in automated systems
- Multiple checking functions ensure proper contact for reliable measurements
  Low-power resistance mode measures chip inductors and EMC suppression
- componentsSupports sample inspections during the manufacturing process

#### Model No. (Order Code) RM3542

**RM3542-01** (Built-in GP-IB interface)

 $Test fixtures \ are \ not \ supplied \ with \ the \ unit. \ Please \ select \ an \ optional \ test \ fixture \ when \ ordering.$ 

Basic specifications (Accuracy guaranteed for 1 year)

Resistance range	[at Low Power OFF] 100 m $\Omega$ range (max. 120.0000 m $\Omega$ , 0.1 $\mu\Omega$ resolution) to 100 M $\Omega$ range (max. 120.0000 M $\Omega$ , 100 $\Omega$ resolution), 10 steps [at Low Power ON] 1000 m $\Omega$ range (max. 1200.000 m $\Omega$ , 1 $\mu\Omega$ resolution) to 1000 $\Omega$ range (max. 1200.000 $\Omega$ , 1 m $\Omega$ resolution), 4 steps
Display	Monochrome graphic LCD $240 \times 64$ dot, white LED backlight
Measurement accuracy	[with SLOW mode, at 100 m $\Omega$ range] $\pm 0.015$ % rdg $\pm 0.002$ % f.s. [with SLOW mode, at 1000 $\Omega$ range] $\pm 0.006$ % rdg $\pm 0.001$ % f.s. (the best case)
Testing current	[at 100 m $\Omega$ range] 100 mA DC to [at 100 M $\Omega$ range] 100 nA DC
Open-terminal voltage	20 V DC max.
Sampling rate	FAST, MEDIUM, SLOW, 3 settings
Measurement times	[at 100 Ω/1000 Ω ranges, with Low Power OFF] FAST: 0.9 ms, MED: 3.6 ms, SLOW: 17 ms (minimum time)
Integration time	0.1 ms to 100.0 ms, or 1 to 5 PLC at 50 Hz, 1 to 6 PLC at 60 Hz Note: PLC = one power line cycle (mains wave-form period)
Other functions	Comparator (compare setting value with measurement value), Delay (set to allow for mechanical delay of trigger input and probing, or set to allow for measure- ment object response), OVC (offset voltage compensation), Measurement fault detection, Probe short-circuit detection, Improve contact, Auto-memory, Statistical calculations, Settings monitor (when using two instruments, a dif- ference in settings causes warning notification), Retry, Trigger function. etc,.
Interfaces	RS-232C, Printer (RS-232C), GP-IB (Model RM3542-01)
External I/O	Trigger, Hold input, Comparator output, Settings monitor terminal
Power supply	100 V to 240 V AC, 50 Hz/60 Hz, 30 VA max.
Dimensions and mass	$260\ mm\ (10.24\ in)\ W\times 88\ mm\ (3.46\ in)\ H\times 300\ mm\ (11.81\ in)\ D,\ 2.9\ kg\ (102.3\ oz)$
Included accessories	Power cord ×1, EXT. I/O male connector ×1, Instruction manual ×1, Operation guide ×1



### **Battery Testers**

### For estimating and approaching the ideal slurry internal state



- A proprietary Hioki algorithm analyzes impedance measured values for LiB . electrode slurries.
- Analysis Results "DCR, Rratio, Uniformity" indicate electron conductivity of Slurry.
- The latest version is available anytime by a Cloud-based, easy-to-use analysis tool.
- Able to choose license plan, fit the right solution for your needs.
- Easily measure the impedance of slurry in the measurement environment recommended by HIOKI.

Model No. (Order Code) SA2631-01	(License card, the period of use is 3 consecutive days.)
SA2631-03	(License card, the period of use is 30 consecutive days.)
SA2631-05	(License card, the period of use is 365 consecutive days.)
SA9001	(ELECTRODE CELL, sold in lots of 50.)
SA9002	(SA9001 dedicated test fixture.)
IM3536	(DC, or 4 Hz to 8 MHz.)
IM3536	(DC, or 4 Hz to 8 MHz.)
IM3536-01	(Special order product: DC, or 4 Hz to 10 MHz.)

\*Please purchase electrode cells and licenses as necessary based on your expected frequency of use and experimental plan. \*Sensitive information will be shared with customers, including during use of analysis functionality.

Customers are responsible for determining whether to make purchases through a retailer

#### ■ Basic specifications (Electrode Cell SA9001)

Material	Container: polypropylene (PP), electrode: brass (nickel plated)
Capacity	Approx. 1 mL
Electrode pin	Diameter (Area where liquid to be measured comes in contact): 3 mm $\pm$ 0.1 mm Electrode interval: 6 mm $\pm$ 0.3 mm
Dimensions and mass	Approx. $27W \times 42H \times 37D \text{ mm} (1.06''W \times 1.65''H \times 1.46''D)$ (including the electrode), approx. 2.3 g (0.1 oz.)

#### Basic specifications (Test Fixture SA9002)

Measurable frequency	DC to 10 MHz
Connectable sample	SA9001 Electrode Cell
Residual imped- ance	Residual resistance during short circuit 200 m $\Omega$ or less (reference for 100 Hz) Inter-electrode stray capacitance 0.2 pF or less (reference for 1 MHz)
Dimensions and mass	Approx. 98W × 38H × 24D mm (3.86"W × 1.50"H × 0.94"D) (excluding protruding parts), approx. 210 g (7.4 oz.)
Included accessory	Shorting plate for compensation

#### Measurement conditions<sup>3</sup>

\*If using an instrument other than the IM3536 or IM3536-01 - Use the Electrode Cell SA9001. The analytical algorithm assumes use of the SA9001. - Check whether the Test Fixture SA9002 can be connected to the instrument. - Acquire data under the measurement conditions listed below. - Prepare a CSV file to send to the system.

Measurement parameters	Frequency, Rs (ReZ), X (ImZ)
Frequency sweep range	4 Hz (+3 Hz) to 10 MHz (-5 MHz)
Number of mea- surement points	Logarithmic interval, 500 points (±10 points)
Applied signal	Constant-voltage, ±100 mV

#### Available material categories

- The system uses the appropriate analytical algorithm to analyze the data based on the selected material category combination. - You may not be able to select some combinations, and some material categories may not be available. If you encounter this issue, perform the analysis using the default model. - There's no need to specify material proportions. - In some cases, the system may not be able perform analysis. - Hioki plans to add material categories over time.

Active materials	LCO, NMC, NCA, LMO, LFP, Graphite, LTO, Si, SiO, None
Conductive aid	Acetylene black, Carbon nanotube, Graphite
Binder	PVDF, SBR, None
Dispersant	CMC, MC, PVP, None
Solvent	NMP, Water

### Quantify Composite Layer Resistance and Interface Resistance in Li-ion Battery Electrode Sheets Basic specifications

### ELECTRODE RESISTANCE MEASUREMENT SYSTEM RM2610



- Isolate and quantify composite layer resistance and interface resistance\* in positive- and negative-electrode sheets used in lithium-ion batteries.
- Composite layer resistance values and interface resistance\* values are helping LIBs to evolve and improve.
- \* Contact resistance of current collector and material laver.
- Verify the uniformity of LIB electrode sheets.
- Visualize variations in composite layer resistance and interface resistance caused by differences in materials, composition, and manufacturing conditions.

Model No. (Order Code) RM2610 (system product)

#### Measurement Positive and negative electrode sheets for rechargeable lithium-ion batteries target Composite resistivity [\Ocm] Measurement Interface resistance (contact resistance) between the composite layer parameters and current collector [\Omegacm2] Computation Inverse problem analysis of potential distribution using the finite volmethod ume method Information nec-Composite layer thickness [µm] (for 1 side) essary for compu Current collector thickness [µm] Current collector volume resistivity [Ωcm] tation Contact check + potential measurement : approx. 30 sec. Calculation : approx. 35 sec. (on a PC with Intel core i5-7200U CPU) Measurement time The measurement time may vary depending on the measurement target and the processing capacity of the PC. Measurement cur-1 µA (min.) to 10 mA (max.) rent Number of probes 46 CPU: 4 or more threads Recommended RAM: 8 GB or greater (4 GB required) PC specifications Operating system: Windows 7 (64-bit), 8 (64-bit), 10 (64-bit) Temperature mea Measures temperature near the test fixture surement function TEMPERATURE SENSOR Z2001 ×1, USB cable ×1, USB license key ×1, Included accessories Probe check board ×1, Power cord ×1, Instruction manual ×1 \*The RM2611 Electrode Resistance Meter requires regular calibration. For more information about cali-

bration, please contact your HIOKI distributor

